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Trends in high speed ADC design

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ASICON A. Matsuzawa



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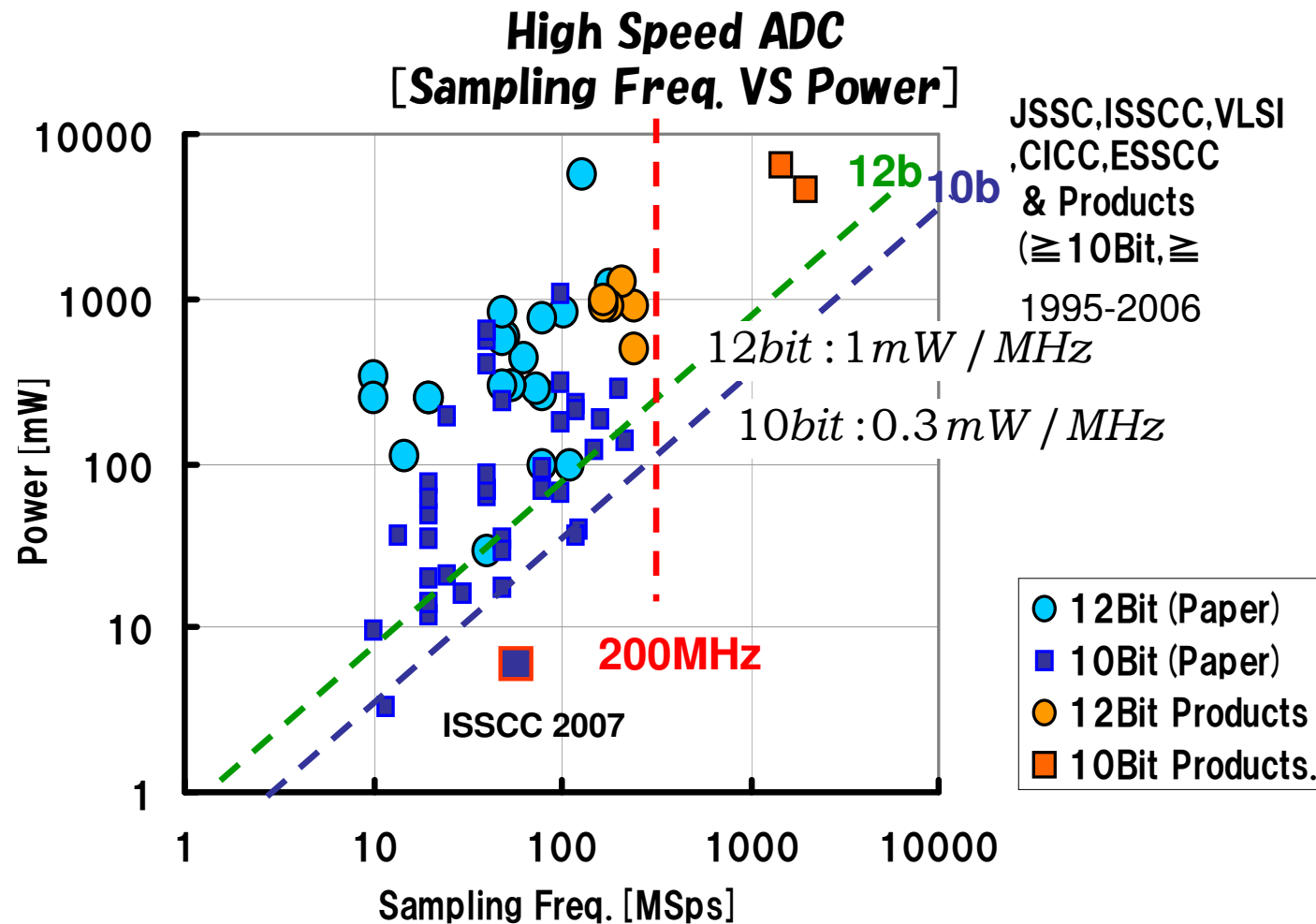
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Speed and power

Conversion speed has saturated at 200 MHz

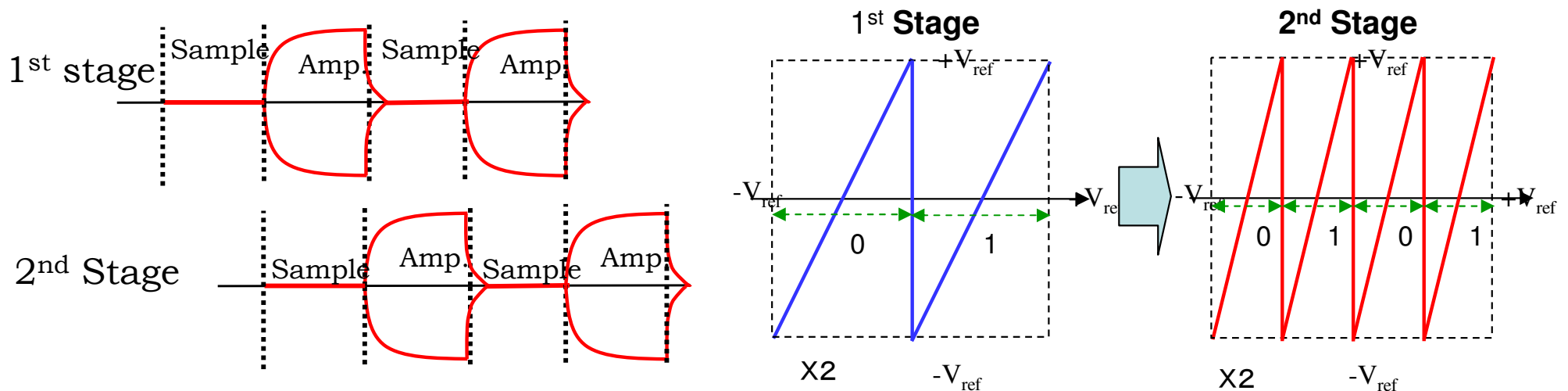
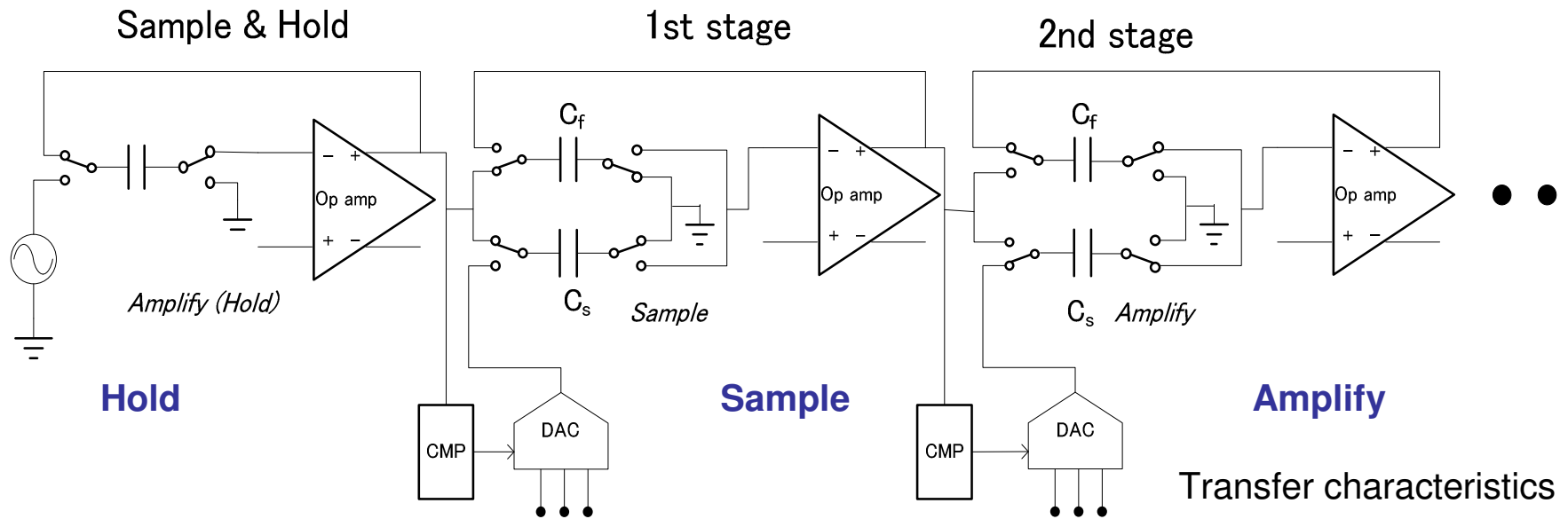
Smaller mW/MHz is needed for low power operation.

0.3mW/MHz for 10bit and 1mW/MHz for 12bit are the bottom lines.



Pipelined ADC

Folding I/O characteristics makes higher resolution along with pipeline stages.

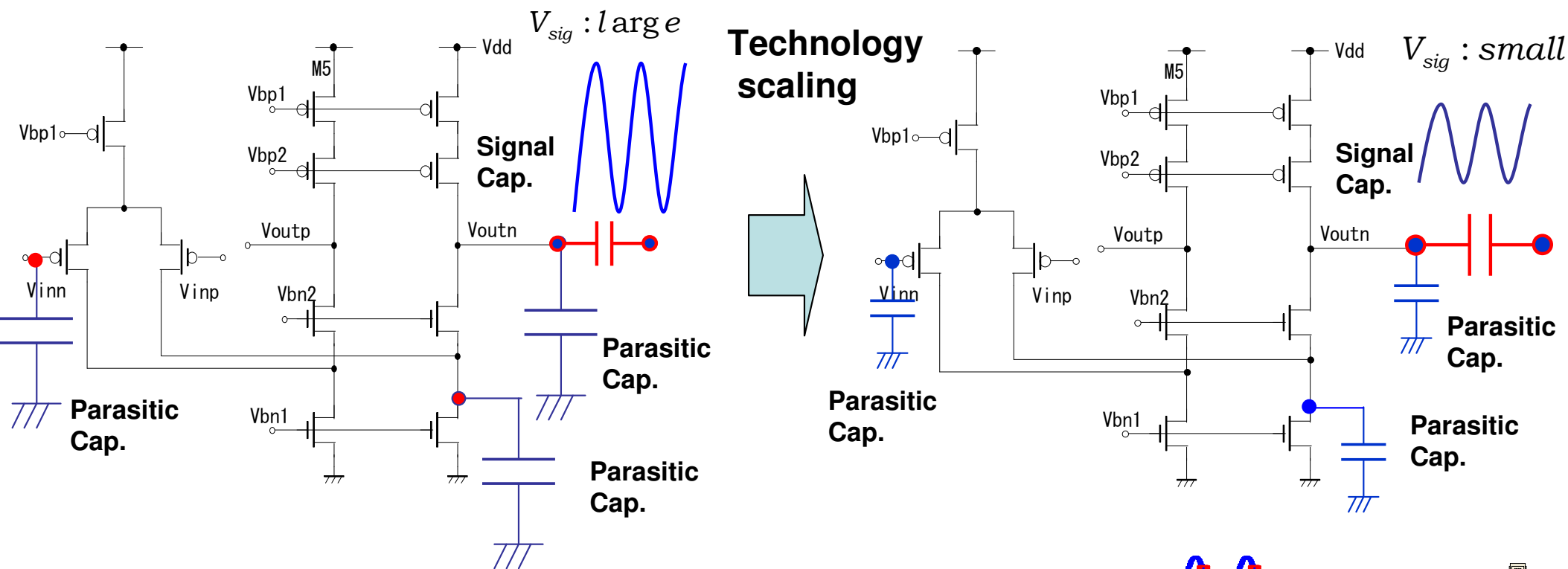


Technology scaling for analog

Technology scaling can reduce parasitic capacitances.
However signal capacitance will increase to keep the same SNR at lower voltage operation.

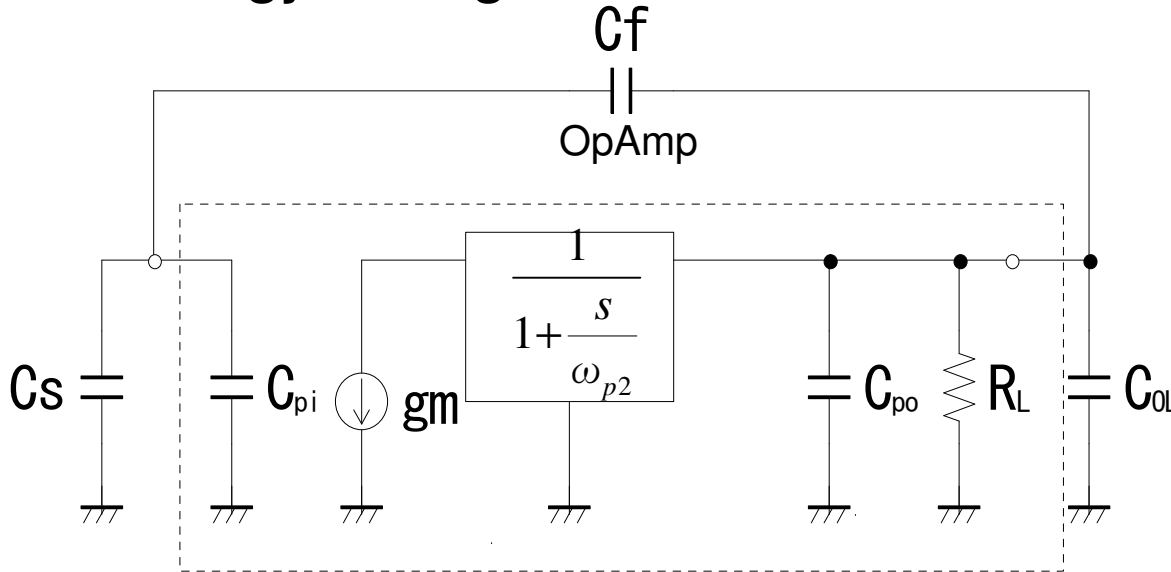
Parasitic capacitance → smaller
Operating voltage → lower
Signal swing → lower

Signal capacitance → larger
Voltage gain → lower



Performance model for pipelined ADC

We have developed the performance model for pipeline ADC that can treat technology scaling.



A. Matsuzawa, "Analog IC Technologies for Future Wireless Systems," IEICE, Tan on Electronics, Vol. E89-C, No.4, pp. 446-454, April, 2006.

$$GBW_{-close} = \frac{g_m}{2\pi C_L} \beta$$

$$\beta = \frac{C_f}{C_f + C_s + C_{pi}}$$

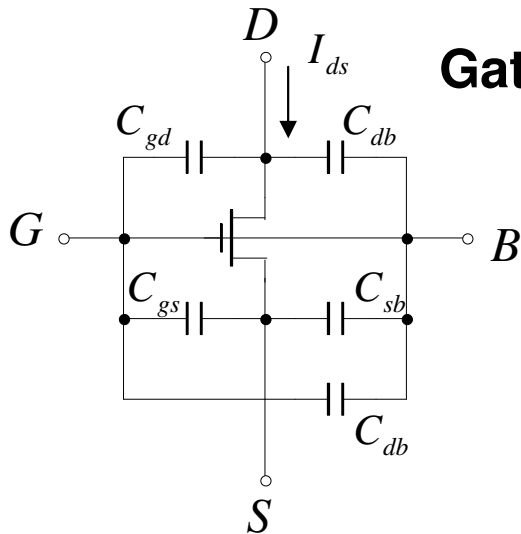
$$C_L = C_{po} + C_{oL} + \frac{C_f(C_s + C_{pi})}{C_f + C_s + C_{pi}}$$

$$C_{oL} = \frac{C_s + C_f}{2} \quad C_o = C_s = C_f = C_{oL}$$

- g_m : Transconductance of input stage
- C_s, C_f : Signal capacitance for feedback loop
- C_{pi}, C_{po} : input & output parasitic capacitance
- C_{oL} : Load capacitance
- R_L : Output resistance
- ω_{p2} : Second pole of OpAmp

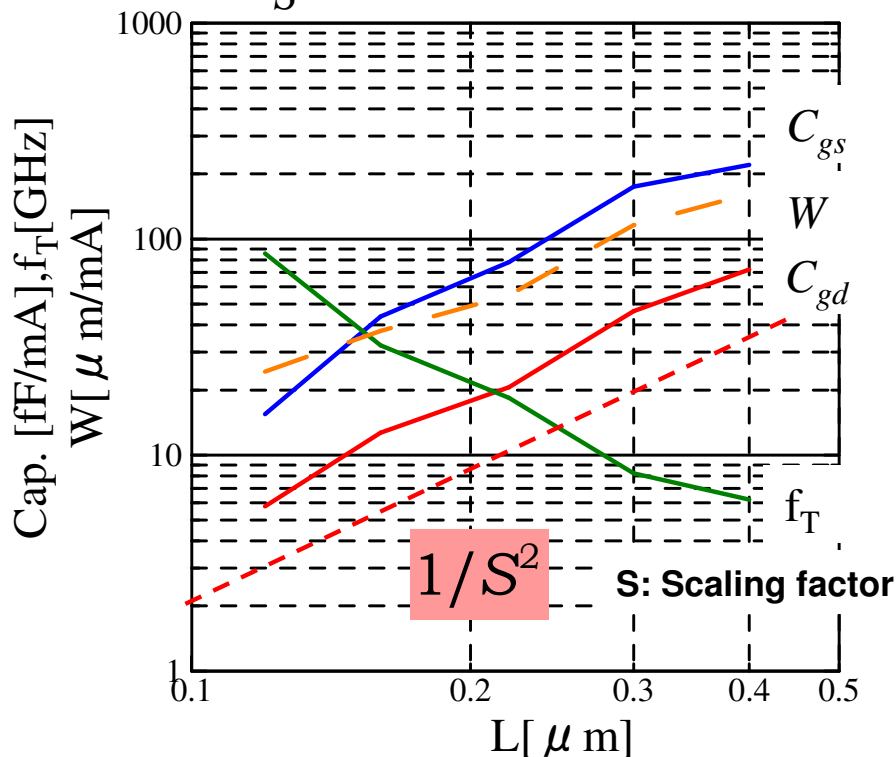
$$GBW_{-close} = \frac{g_m}{2\pi C_o} \frac{1}{\left(2 + \frac{C_{pi}}{C_o}\right) \left(1 + \frac{C_{po}}{C_o}\right) + \left(1 + \frac{C_{pi}}{C_o}\right)} = \frac{I_{ds}}{\pi C_o V_{eff}} \frac{1}{\left(2 + \frac{\alpha_{pi} I_{ds}}{C_o}\right) \left(1 + \frac{\alpha_{po} I_{ds}}{C_o}\right) + \left(1 + \frac{\alpha_{pi} I_{ds}}{C_o}\right)}$$

Gate width and capacitances decrease with technology scaling.



$$V_{eff} = 0.175V$$

$$W = \frac{2L}{\mu C_{ox} V_{eff}^2} I_{ds}$$



(a) $W_N, W_P [\mu m/mA], V_{A_N}, V_{A_P} [V]$

| DR | W_N | W_P | V_{A_N} | V_{A_P} |
|--------------|-------|-------|-----------|-----------|
| 90nm | 24.3 | 74.9 | 0.82 | 0.69 |
| 0.13 μm | 37.5 | 147 | 0.82 | 0.64 |
| 0.18 μm | 54.8 | 219 | 0.99 | 0.93 |
| 0.25 μm | 116.0 | 396 | 0.78 | 0.97 |
| 0.35 μm | 162.0 | 603 | 1.01 | 0.86 |

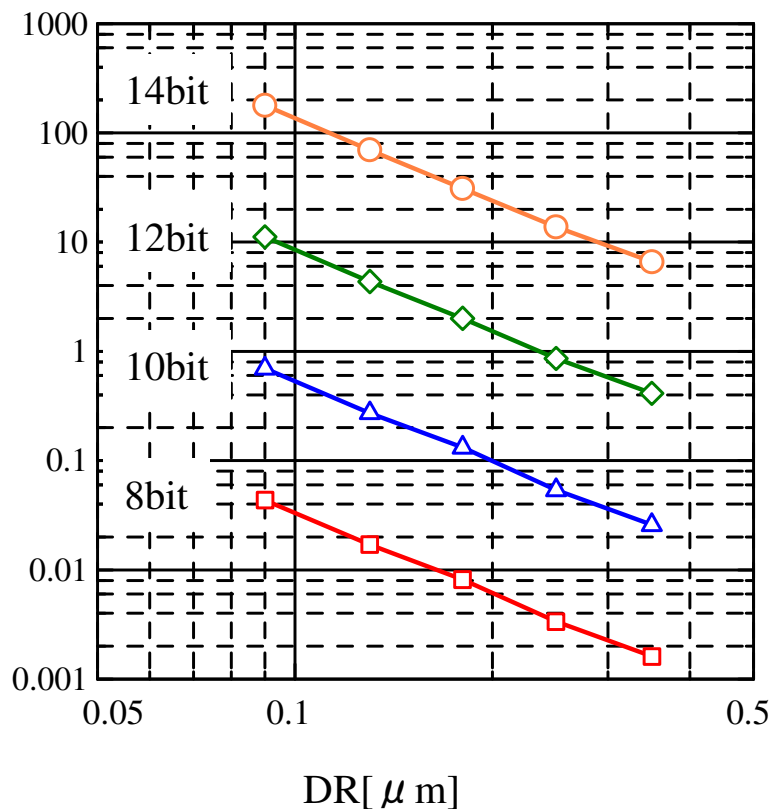
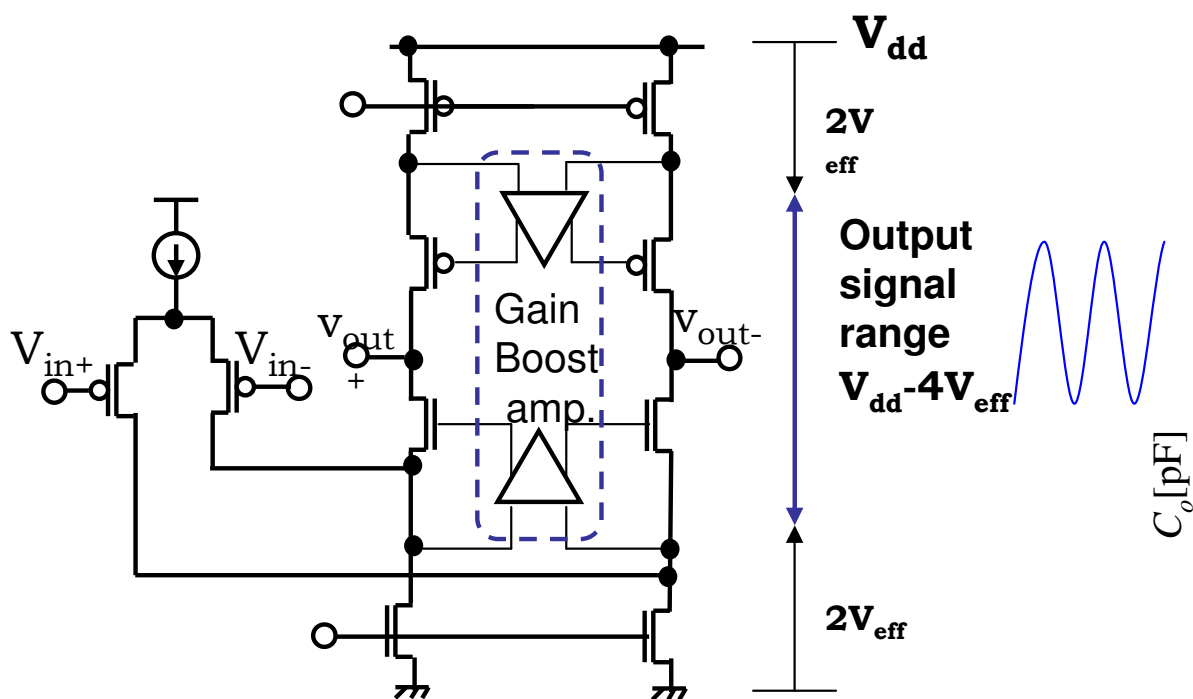
(b) $C_{pi_N}, C_{pi_P}, C_{po} [fF/mA], \omega_{p2_N}, \omega_{p2_P} [GHz]$

| DR | C_{pi_N} | C_{pi_P} | C_{po} | ω_{p2_N} | ω_{p2_P} |
|--------------|------------|------------|----------|-----------------|-----------------|
| 90nm | 23.7 | 93.4 | 94.5 | 9.35 | 15.4 |
| 0.13 μm | 65.5 | 249 | 168 | 7.7 | 10.3 |
| 0.18 μm | 115 | 475 | 340 | 2.06 | 4.7 |
| 0.25 μm | 236 | 662 | 832 | 0.83 | 1.7 |
| 0.35 μm | 303 | 1034 | 892 | 0.54 | 1.7 |

Determination of signal capacitance

Larger resolution requires larger signal capacitance.
Furthermore, Voltage lowering increases signal capacitance more.

$$C_o \geq 1.66 \times 10^{-19} \left(\frac{2^N}{V_{sig}} \right)^2$$



| | 90nm | 0.13 μm | 0.18 μm | 0.25 μm | 0.35 μm |
|---------------|------|--------------|--------------|--------------|--------------|
| V_{dd} | 1.2V | 1.5V | 1.8V | 2.5V | 3.3V |
| V_{sig_pp} | 1.0V | 1.6V | 2.2V | 3.6V | 5.2V |

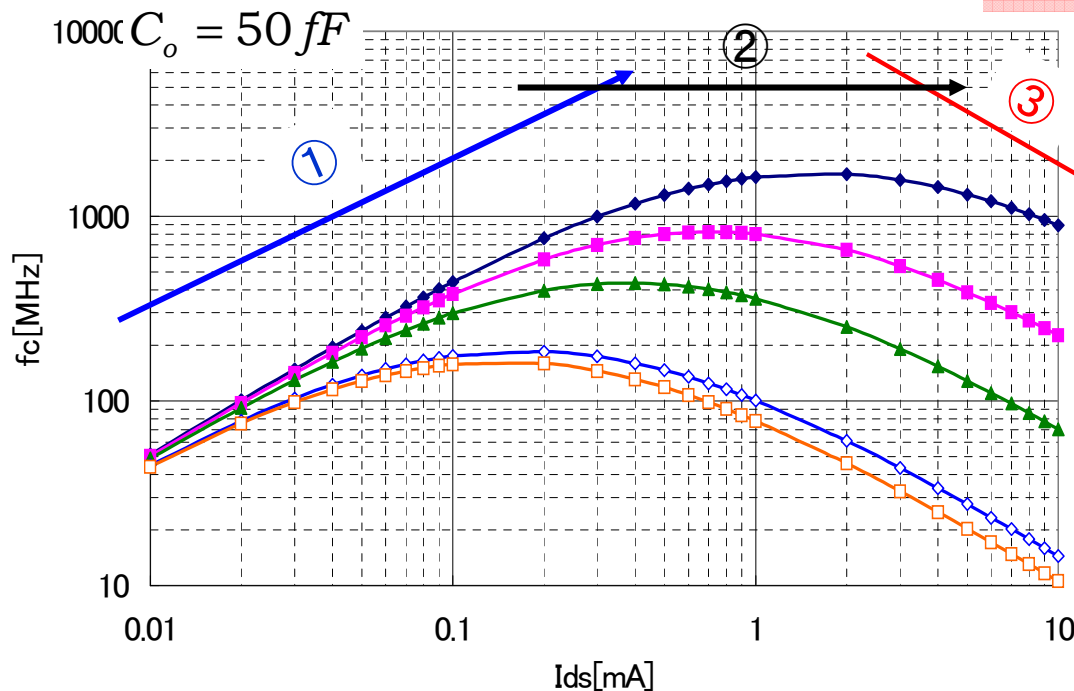
Performance curve

Performance exhibits convex curve.

There is the peak conversion frequency and the optimum current.

Current increase results in increase of parasitic capacitances and decrease of conversion frequency in the higher current region.

$$GBW_{-close} = \frac{I_{ds}}{\pi C_o V_{eff}} \frac{1}{\left(2 + \frac{\alpha_{pi} I_{ds}}{C_o}\right) \left(1 + \frac{\alpha_{po} I_{ds}}{C_o}\right) + \left(1 + \frac{\alpha_{pi} I_{ds}}{C_o}\right)}$$

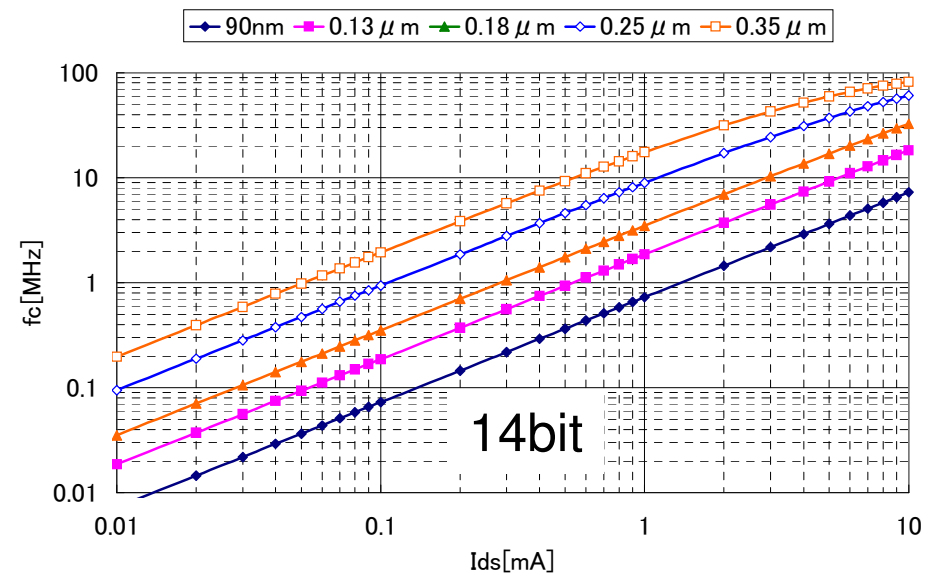
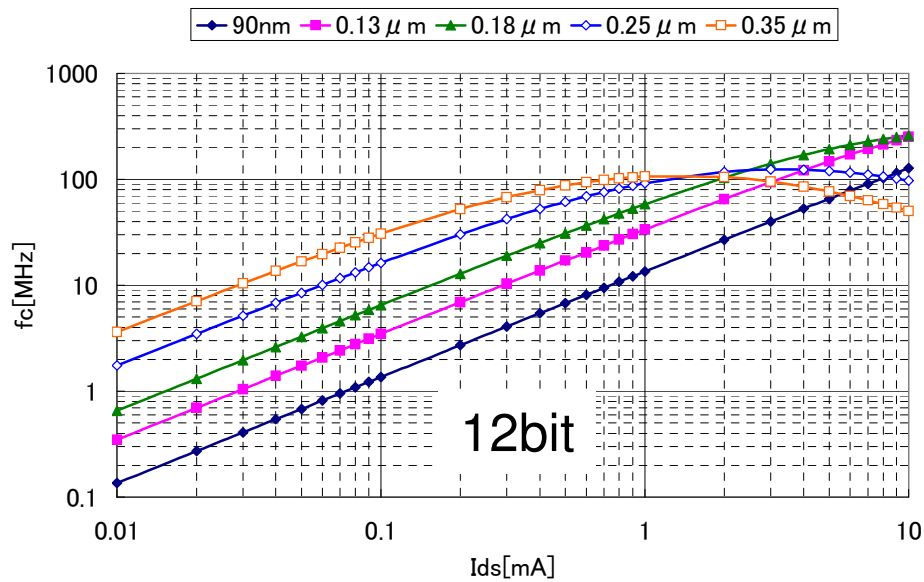
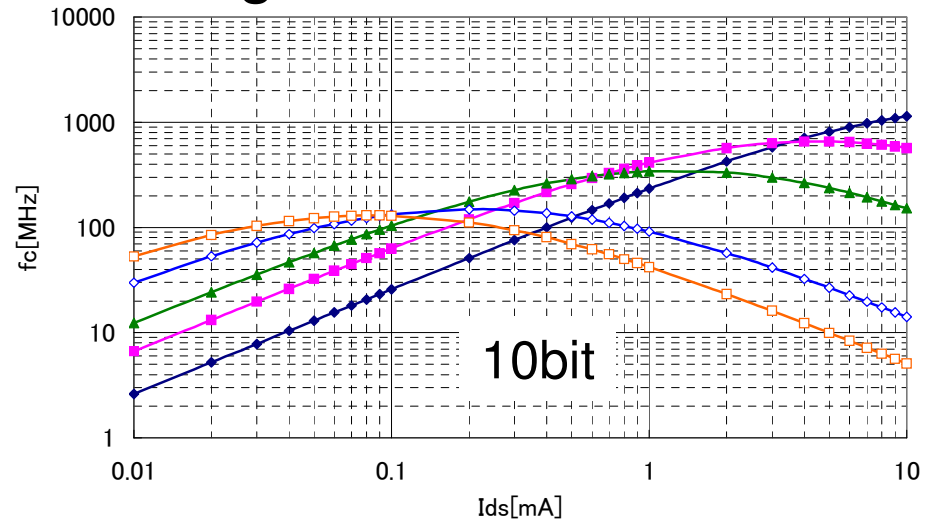
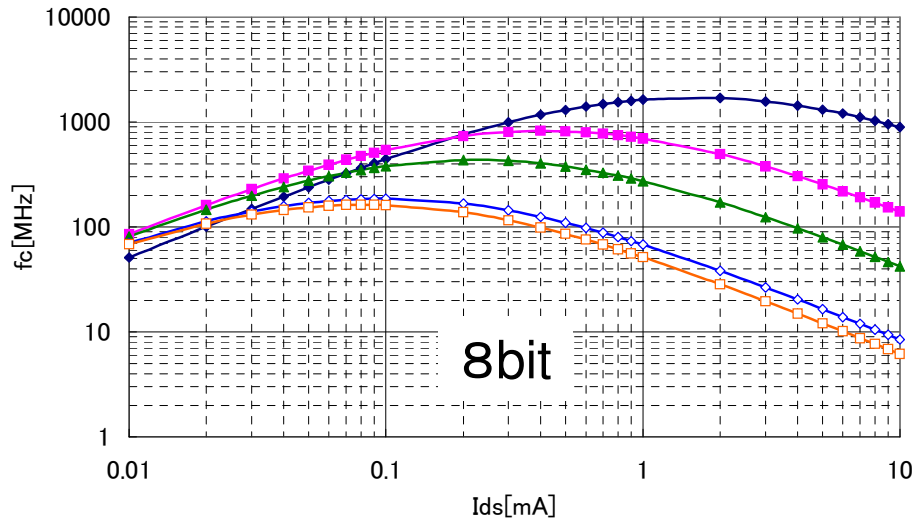


◆ 90nm ■ 0.13 μm ▲ 0.18 μm ◇ 0.25 μm □ 0.35 μm

- ① $C_o \gg C_{po}, C_{pi}$
 $GBW_{-close} \approx \frac{I_{ds}}{\pi C_o V_{eff}} \cdot \frac{1}{3} \quad (\propto I_{ds})$
- ② $C_{pi} < C_o < C_{po}$
 $GBW_{-close} \approx \frac{1}{\pi C_o V_{eff}} \cdot \frac{1}{3 + \alpha_o} \quad (Constant)$
- ③ $C_o < C_{po}, C_o < C_{pi}$
 $GBW_{-close} \approx \frac{1}{\pi C_o V_{eff}} \cdot \frac{1}{3 + \alpha_i \alpha_o I_{ds}} \quad (\propto \frac{1}{I_{ds}})$

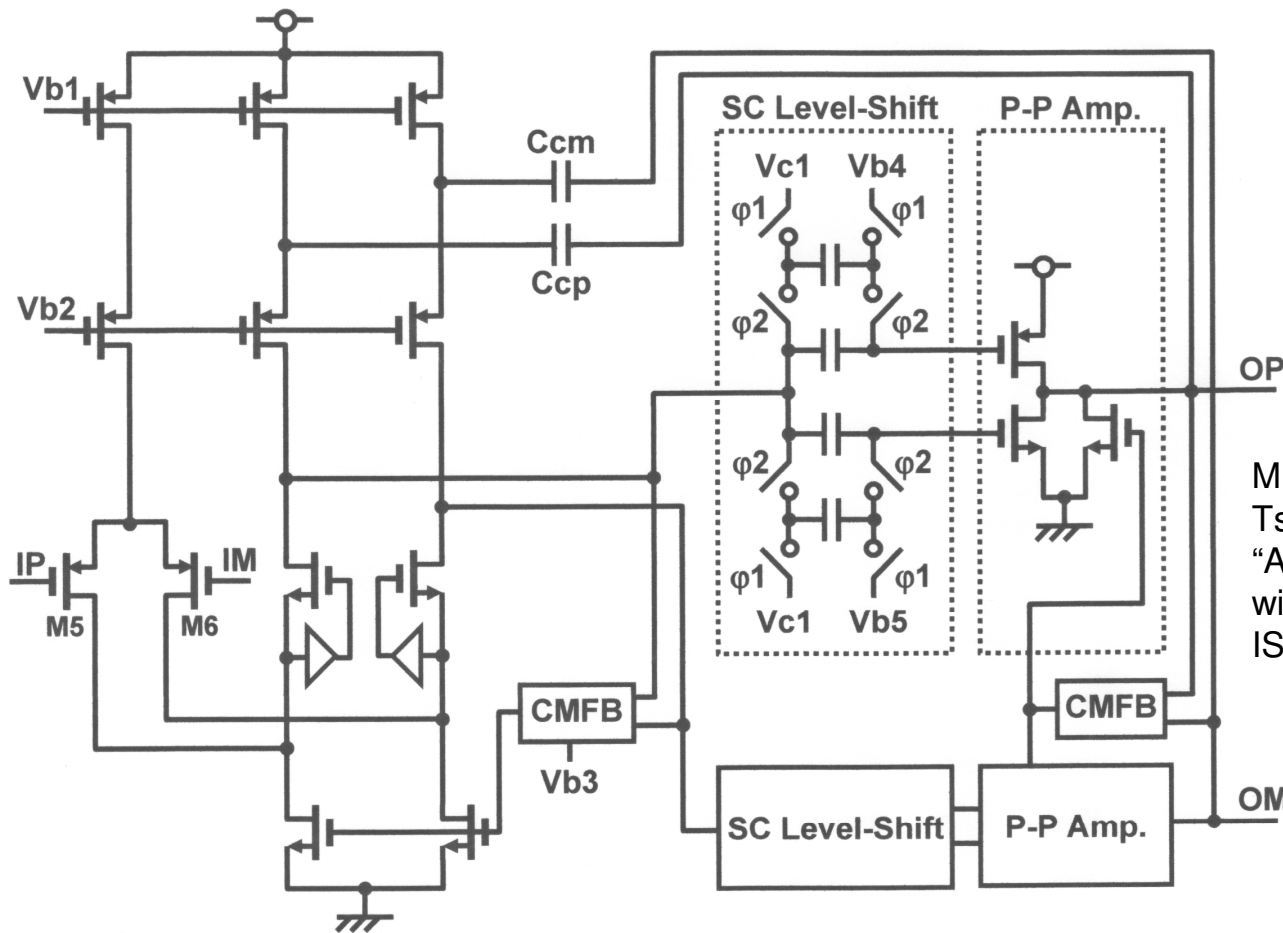
Performance summary

Scaled CMOS is effective for just low resolution ADC.
Scaled CMOS is not effective for high resolution ADC.



Optimization of OpAmp in Pipelined ADC

90nm CMOS, near sub-threshold operation, and SC level-shift have realized 10bit 80MHz ADC with 0.8V operation and small power of 6.5mW



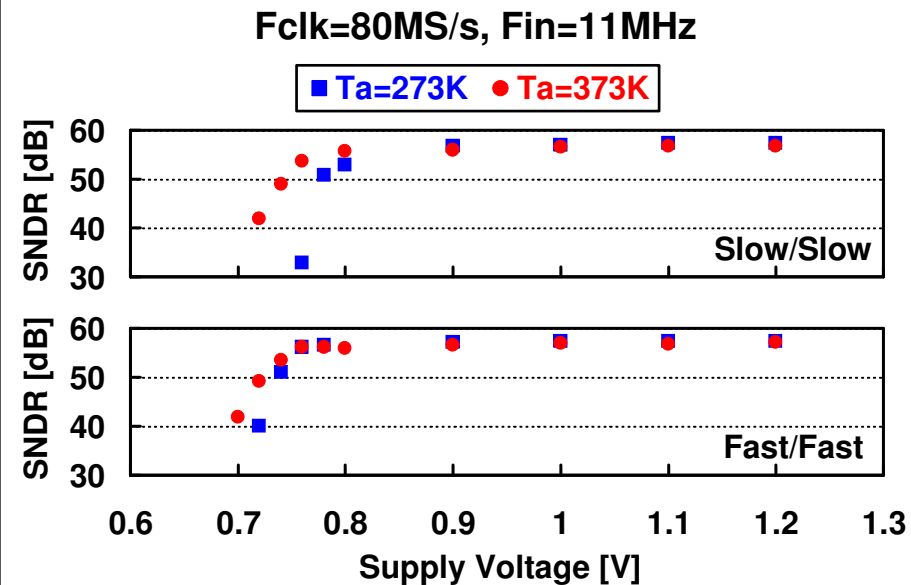
M. Yoshioka, M. Kudo, T. Mori, and S. Tsukamoto
"A 0.8V 10b 80MS/s 6.5mW Pipelined ADC with Regulated Overdrive Voltage Biasing,"
ISSCC, Dig. Tech. paper, pp. 452-453, 2007.

Figure 25.1.2: Schematic of two-stage amplifier.

Results

FoM=0.2pJ/step 0.08mW/MHz

| | | |
|--------------------------------|---|---|
| Technology | 1P10M 90nm CMOS with MIM Capacitors | |
| Resolution | 10bit | |
| Conversion Rate | 80MS/s | |
| Active Area | 1.18mm x 0.54mm | |
| Input Range | 1.2Vp-p Differential | |
| Supply Voltage | 0.8V | 1.2V |
| SNDR | 55.0dB @2MHz 51.4dB @41MHz | 56.9dB @2MHz 55.6dB @41MHz |
| Total Power Consumption | 6.5mW | 13.3mW |
| INL | < 1.0LSB | < 0.5LSB |
| DNL | < 0.8LSB | < 0.4LSB |

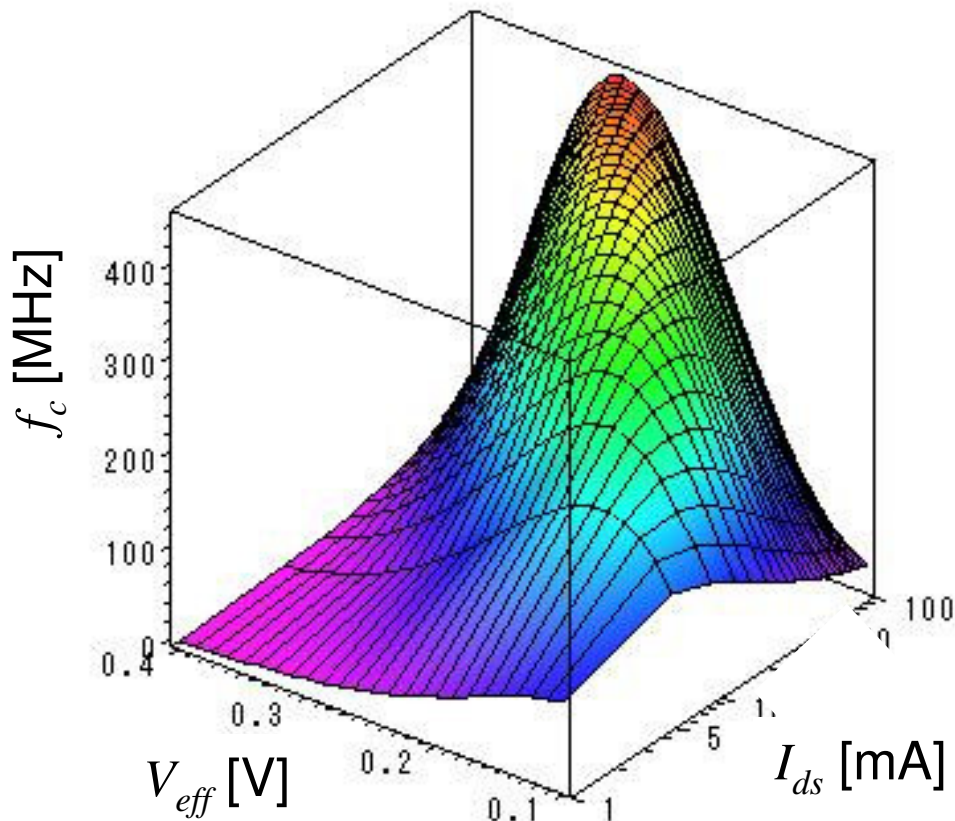


Optimization of V_{eff}

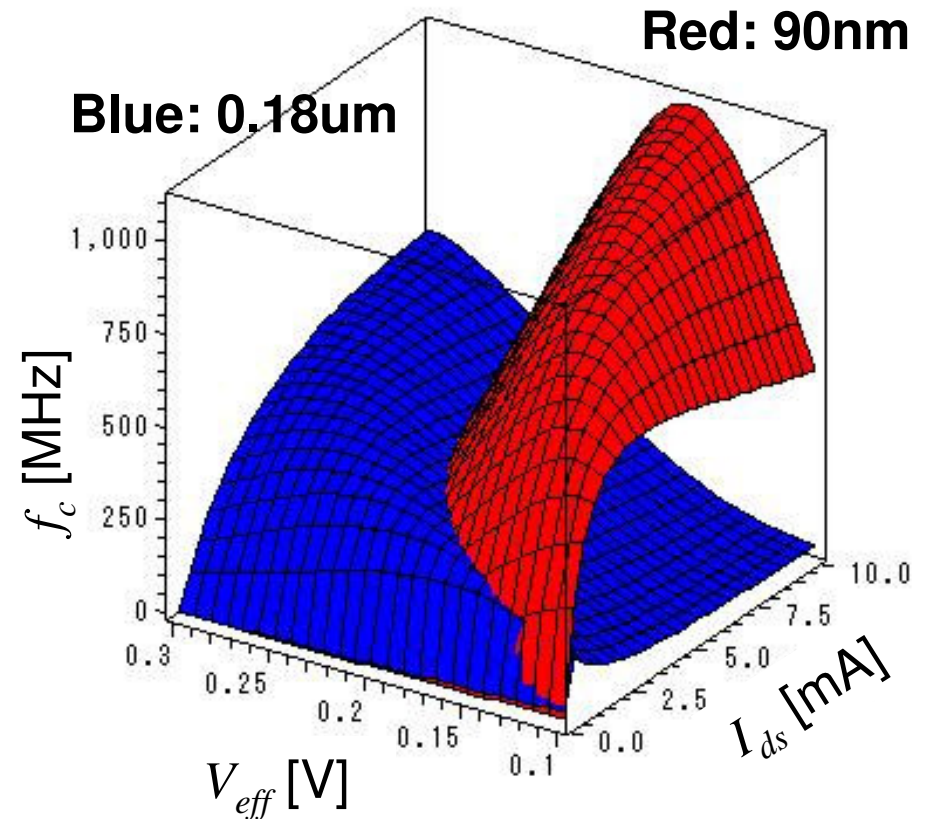
Optimum V_{eff} is a function of resolution, current, and design rule.

The lower V_{eff} is recommended for scaled CMOS technology.

12 bit, 0.18um CMOS



10 bit

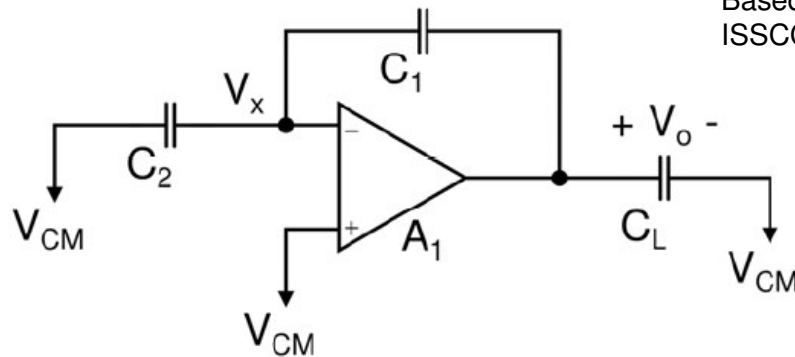


Challenge to realize pipelined ADC without OpAmp

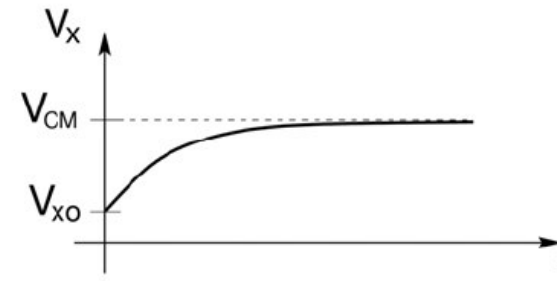
Comparator controlled current source can realize the virtual ground.

Now challenge for not use of OpAmp in ADC design has started.

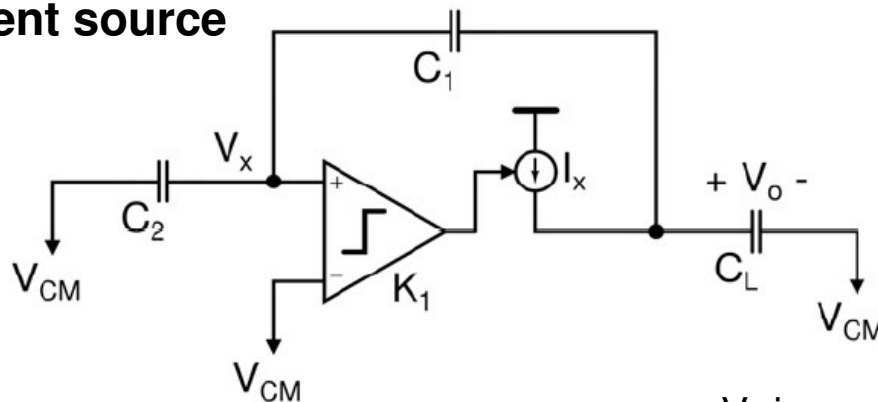
Conventional OpAmp



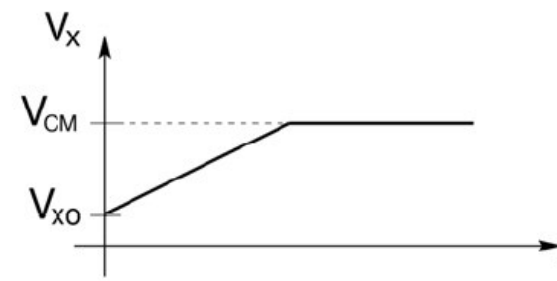
T. Sepke, J. K. Fiorenza, C. G. Sodini, P. Holloway, and H. Lee, "Comparator-Based Switched-Capacitor Circuits For Scaled CMOS Technologies," IEEE, ISSCC 2006, Dig. of Tech. Papers, pp. 574-575. Feb. 2006.



Comparator controlled current source

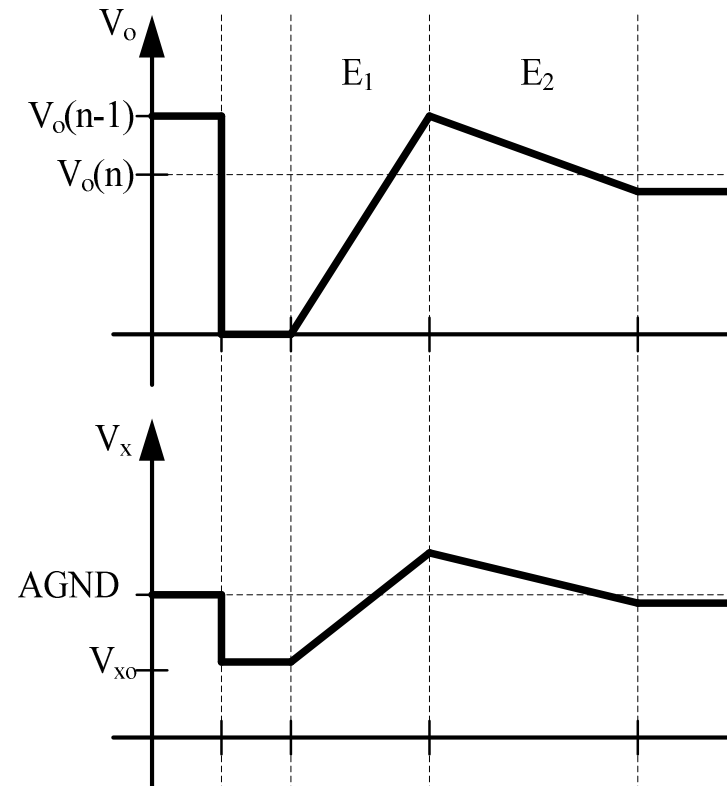
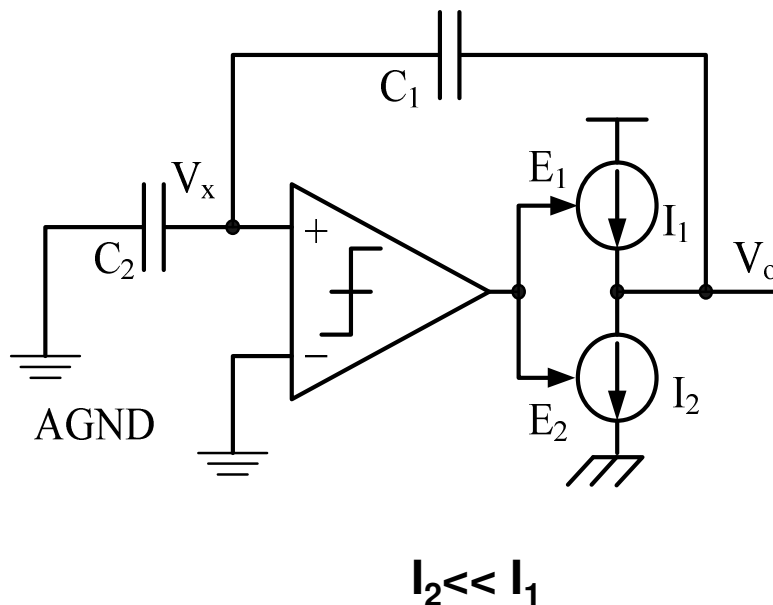


V_x is reaching the virtual ground voltage asymptotically



V_x is reaching the virtual ground voltage with constant rate

Time delay ($V_x \rightarrow V_o$) causes voltage offset. Small inverse current source has been introduced. The offset voltage can be reduced and does not effect the conversion linearity.



T. Sepke, J. K. Fiorenza, C. G. Sodini, P. Holloway, and H. Lee, "Comparator-Based Switched-Capacitor Circuits For Scaled CMOS Technologies," IEEE, ISSCC 2006, Dig. of Tech. Papers, pp. 574-575. Feb. 2006.

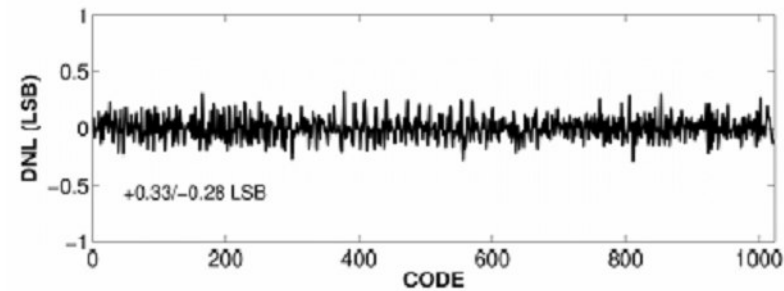
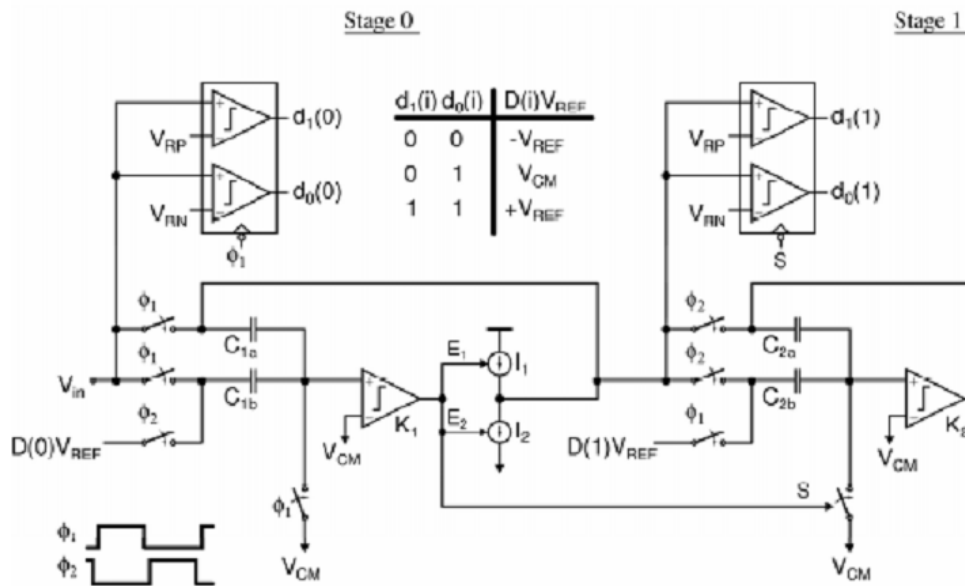
**10b, 8MHz ADC has been developed.
Pd=2.5mW. Lowest Pd/MHz**

Results

Small FoM, however not amazingly

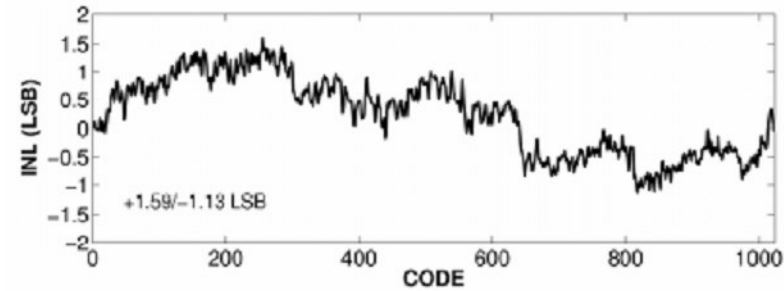
10b ADC

FoM = 0.3pJ/step, 0.3mW/MHz



$f_c = 8\text{MHz}$
Power = 2.5mW

$$\text{FoM} = \frac{P}{f_c \cdot 2^N} = 0.3\text{pJ/b}$$



N=10bit

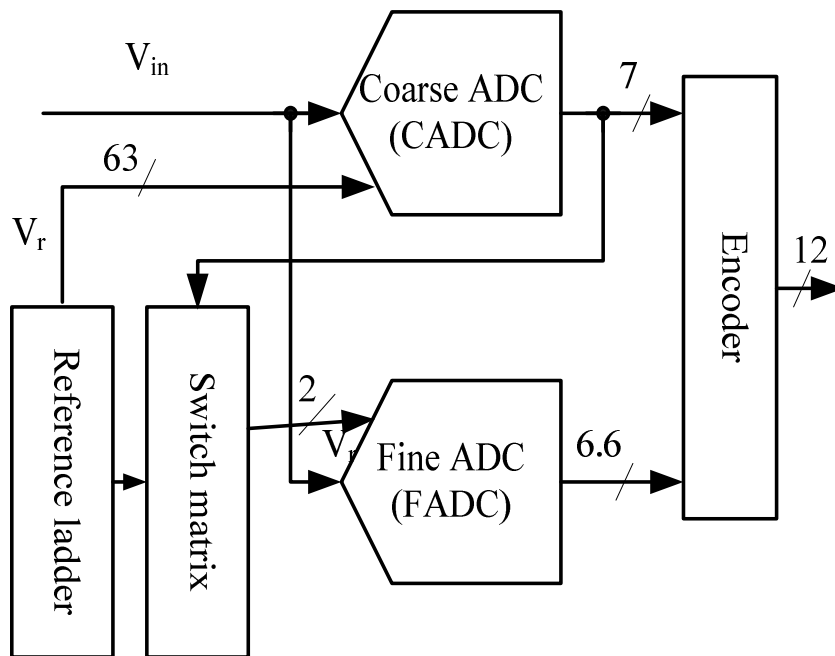
Sub-ranging ADC

Sub-ranging ADC also doesn't require OpAmp and suitable for LV operation. However it requires low offset voltage comparators.

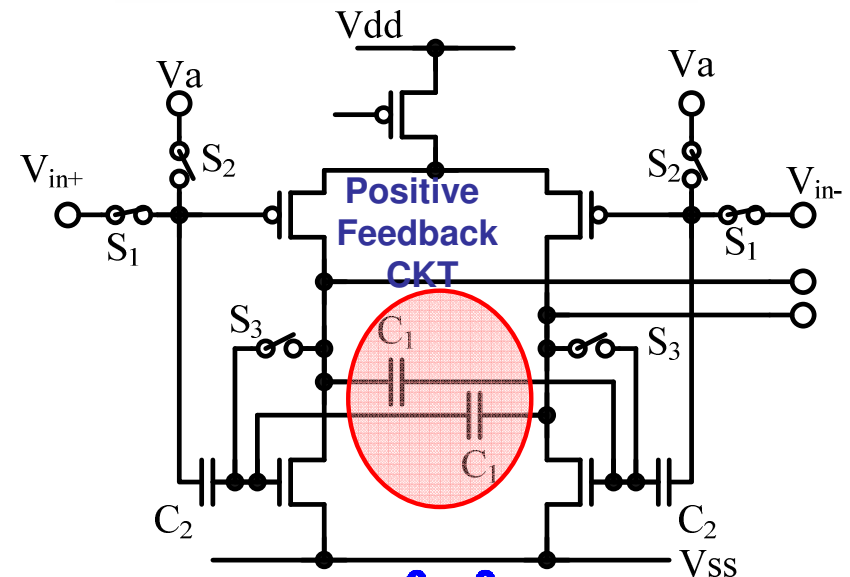
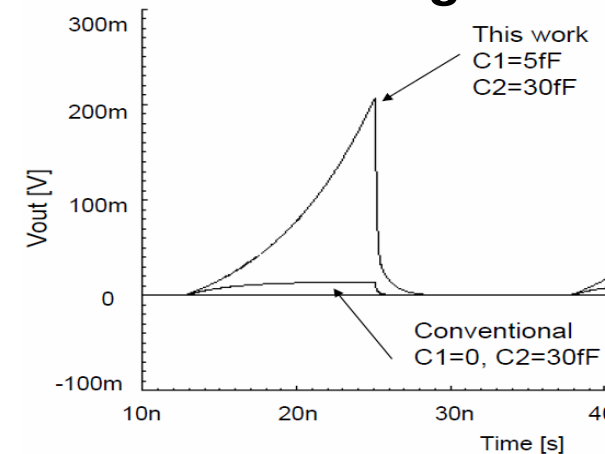
Use of positive feedback technique has realized low offset voltage.

Technology revival has been found.

Pd/MHz = 0.75mW/MHz which is lowest value!!



7]Y. Shimizu, S. Murayama, K. Kudoh, H. Yatsuda, A. Ogawa, "A 30mw 12b 40MS/s Subranging ADC with a High-Gain Offset-Canceling Positive-Feedback Amplifier in 90nm Digital CMOS," IEEE, ISSCC 2006, Dig. of Tech. Papers, pp. 222-225. Feb. 2006.

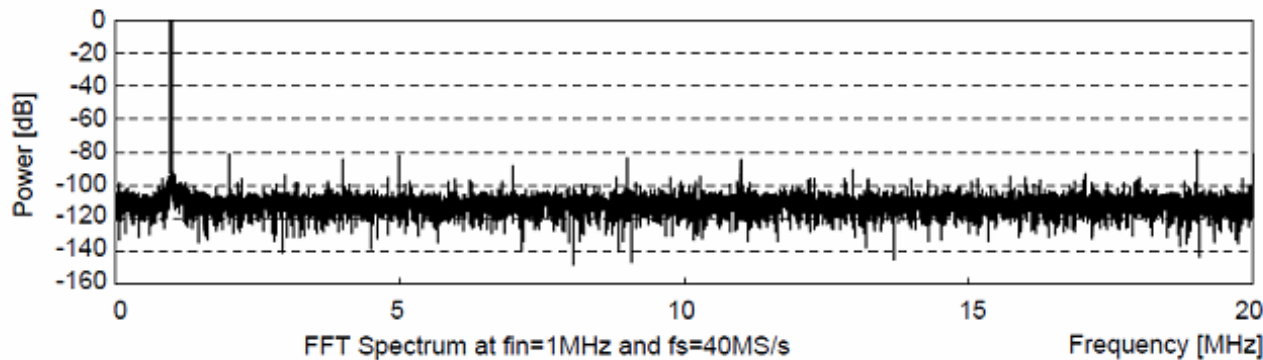
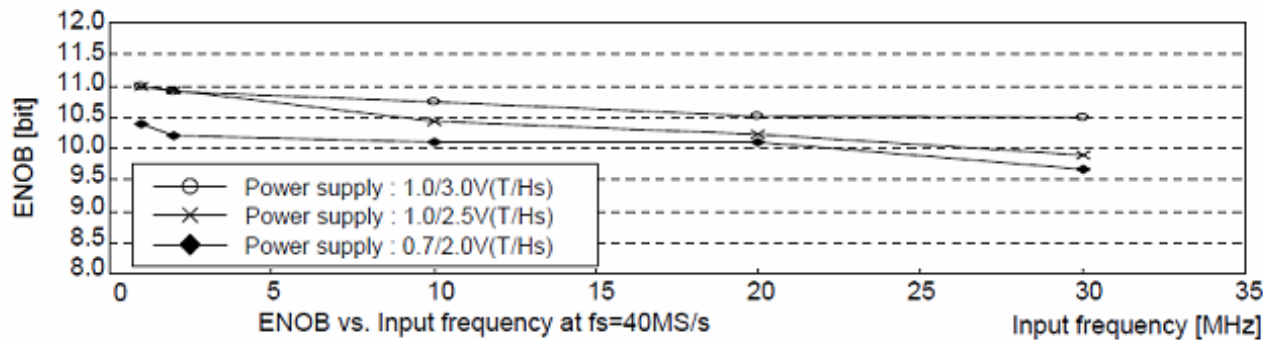
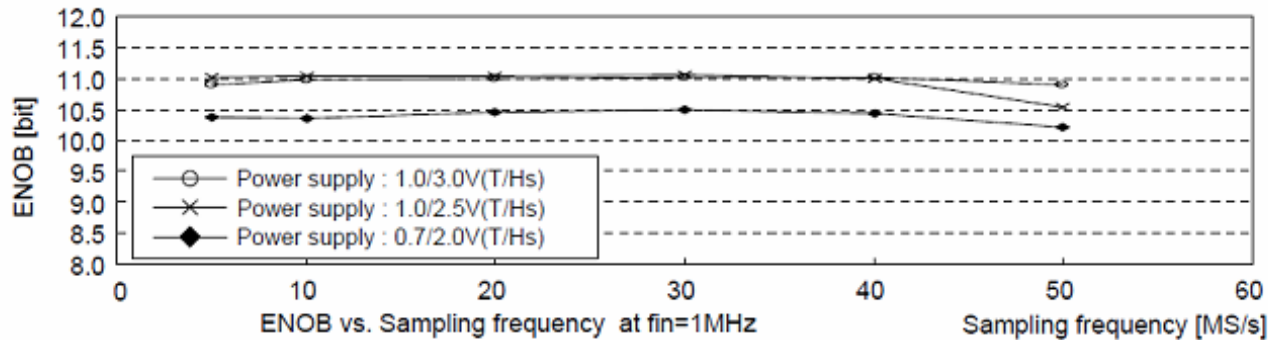


Results

Attain high ENOB of 10.5-11.0
30mW at 40MHz

90nm CMOS 1V Operation

0.4pJ/step



Successive approximation ADC

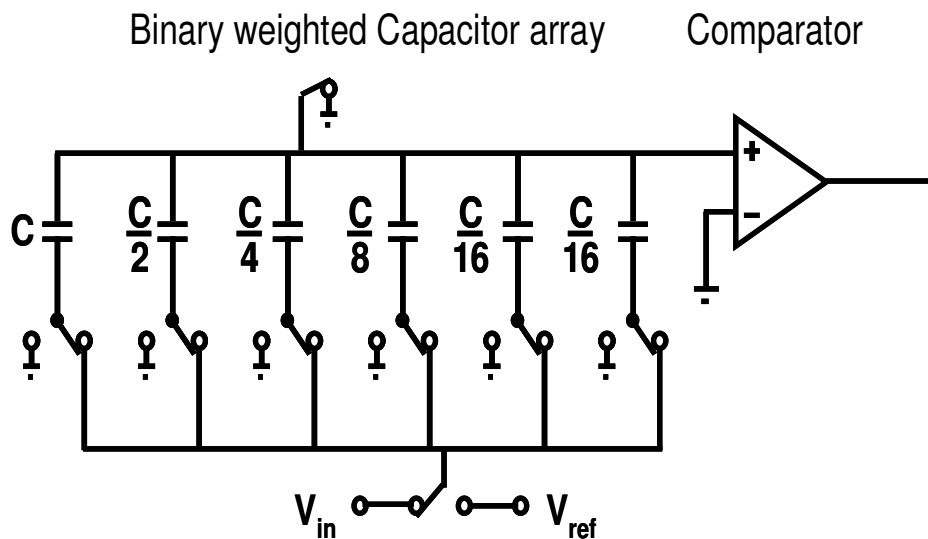
19

Successive approximation ADC has been used long time as a low power and low speed ADC. It doesn't require OpAmp but capacitor array and comparator. Thus this architecture looks suitable for scaled and low voltage CMOS.

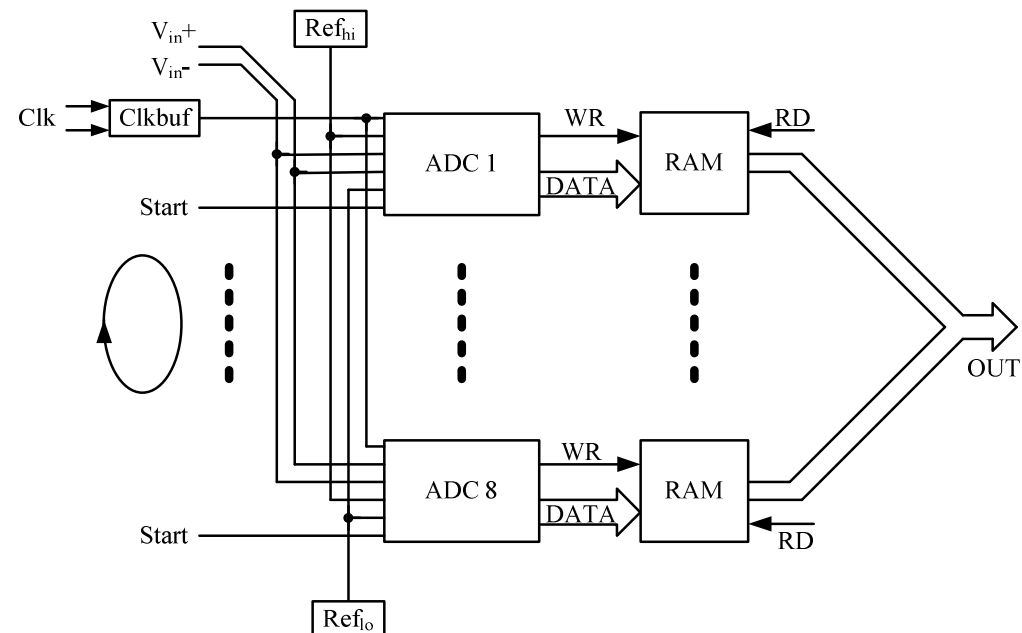
Now challenge for renewal of this conventional architecture has started.

Successive approximation ADC

SA-ADC



Eight interleaved SA-ADCs with 90nm CMOS attain 600MHz operation.

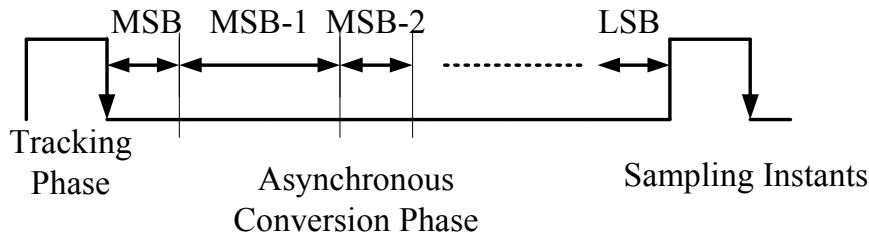
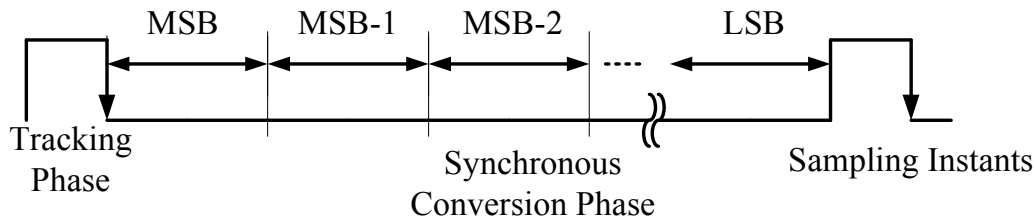


D. Draxelmayr, "A 6b 600MHz 10mW ADC Array in Digital 90nm CMOS," IEEE, ISSCC 2004, Dig. of Tech. Papers, pp. 264-265, Feb. 2004.

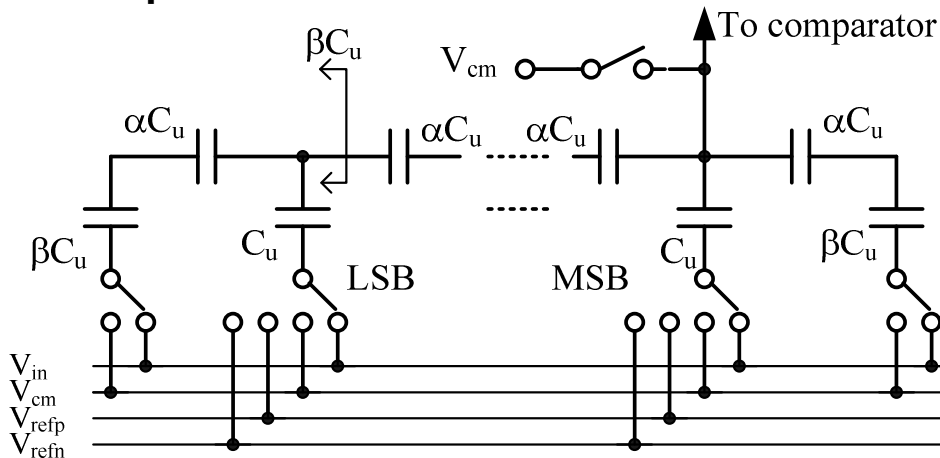
Improvement of SA-ADC

Asynchronous clock increases conversion frequency.
Use of proper radix reduces capacitance.

Asynchronous clock



Capacitor ladder with some radix number



6bit 600MHz 5.3mW ADC has been realized with 0.13um CMOS

$$\beta = 1 + \alpha \parallel \beta$$

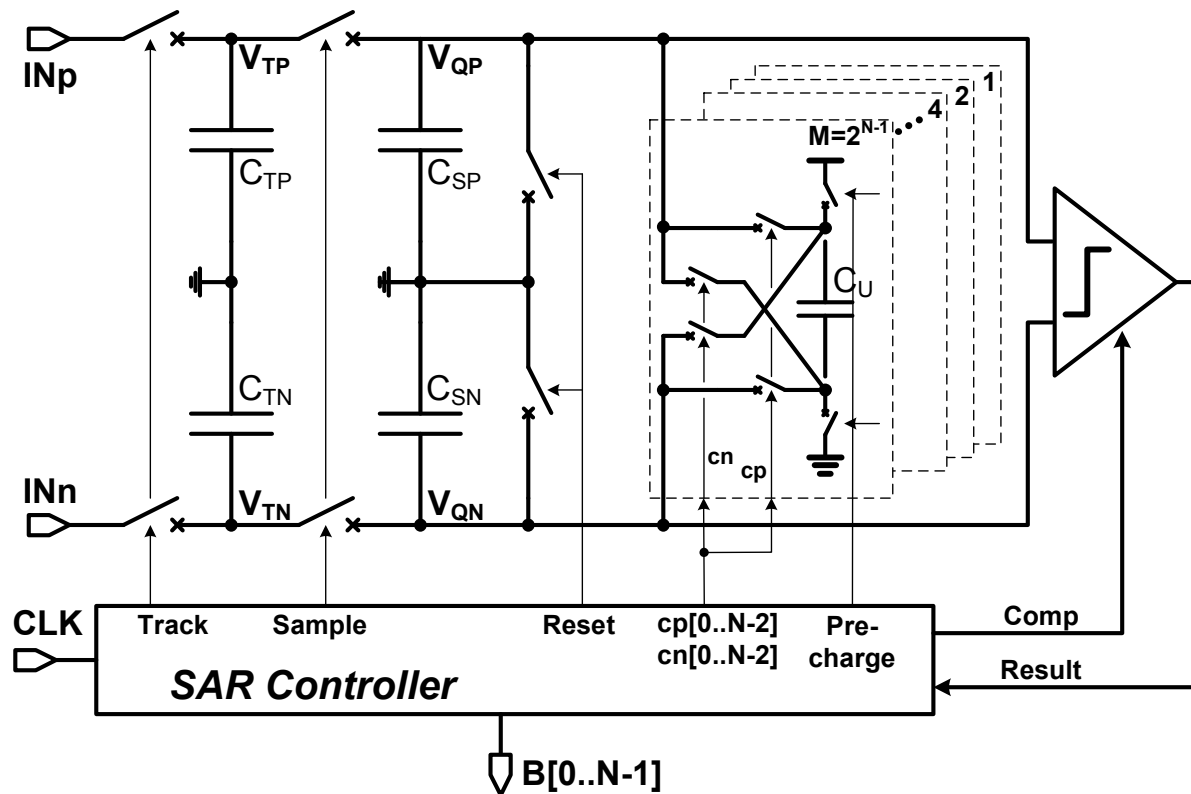
$$radix = 1 + \frac{\beta}{\alpha}$$

S. W. M. Chen and R. W. Brodersen, "A 6b 600MS/s 5.3mW Asynchronous ADC in 0.13um CMOS," IEEE, ISSCC 2006, Dig. of Tech. Papers, pp. 574-575. Feb. 2006.

Newest SAR ADC

SAR ADC must be one of the good solution for scaled analog technology.
No OPamp is needed.

No static power consumption.
Higher signal swing and small capacitance

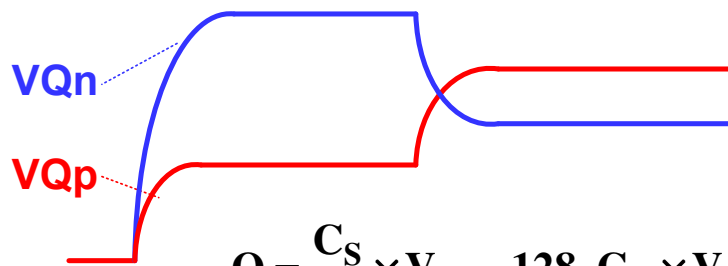
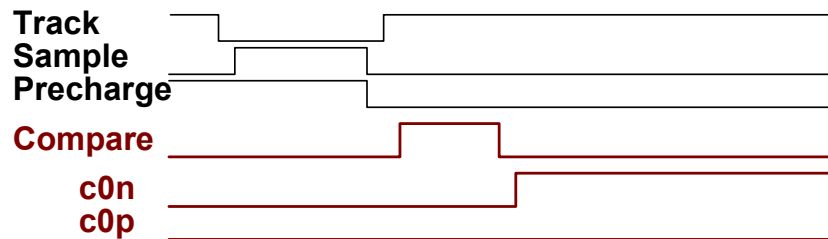
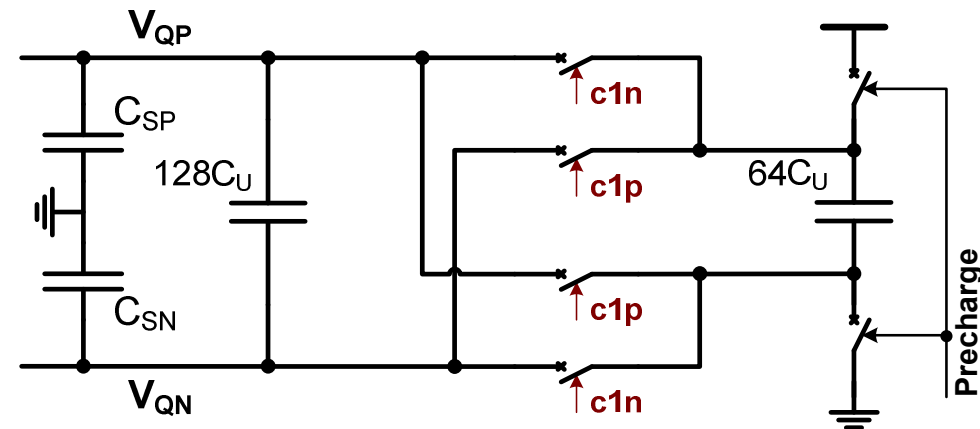
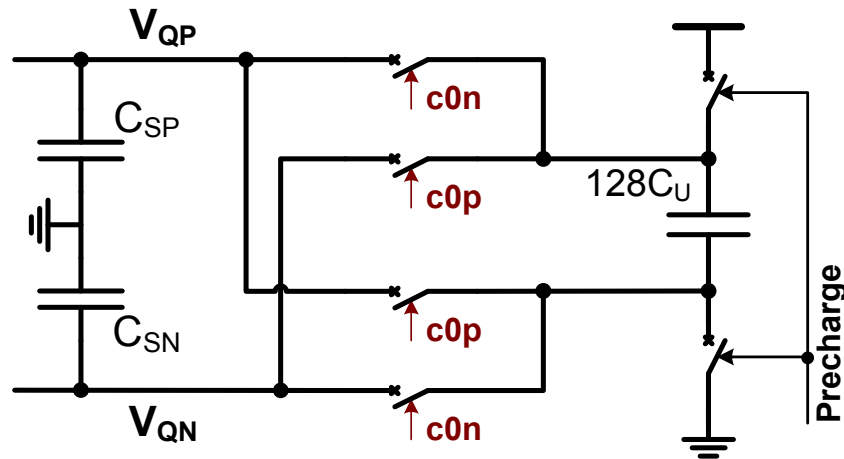


$$Q_{\text{REF}} = \sum_i 2^i C_U \cdot V_{\text{DD}}$$

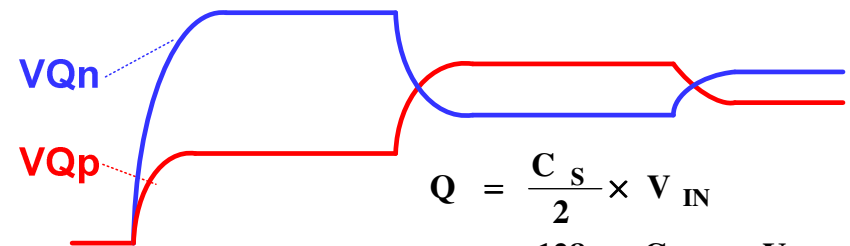
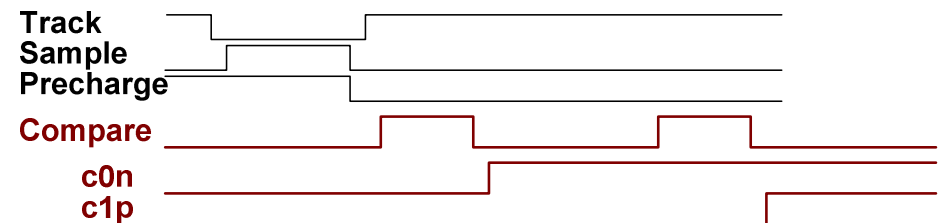
J. Craninckx and G. Van der Plas,
“A 65fJ/Conversion-Step 0-to-0.7mW 9b Charge-Sharing SAR ADC in 90nm Digital CMOS,” IEEE ISSCC 2007, Dig. of Tech. Papers, pp.246-247, Feb. 2007.

Analog operation with capacitances

Capacitances can realize analog operation for SAR ADC.
No static current is required and higher signal swing can be used.



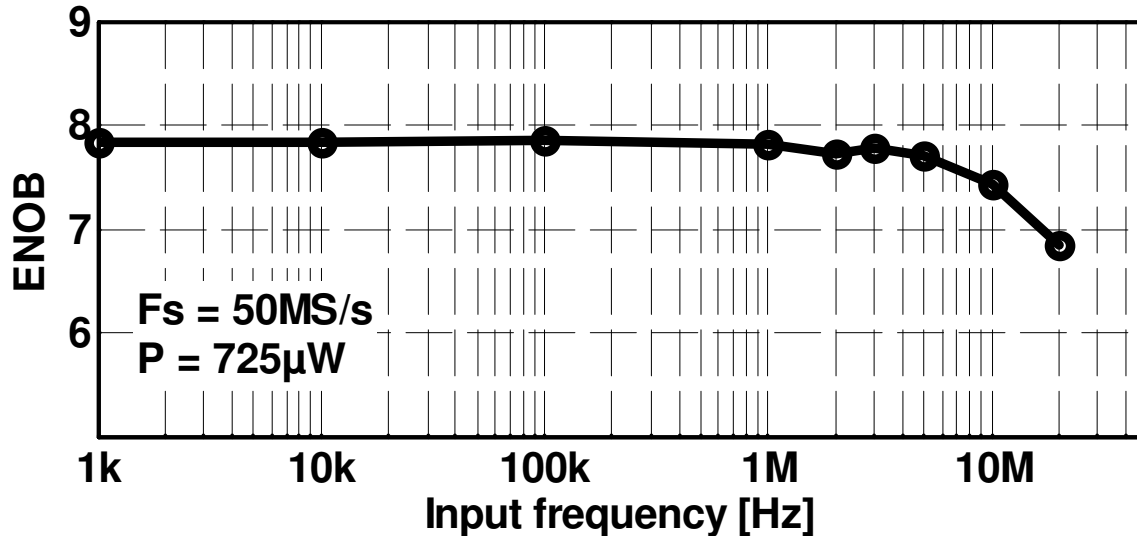
$$Q = \frac{C_S}{2} \times V_{IN} - 128 \cdot C_U \times V_{DD}$$



$$Q = \frac{C_S}{2} \times V_{IN} - 128 \cdot C_U \times V_{DD} + 64 \cdot C_U \times V_{DD} \pm \dots$$

Results

Amazing small FoM=65fJ/step has been attained.



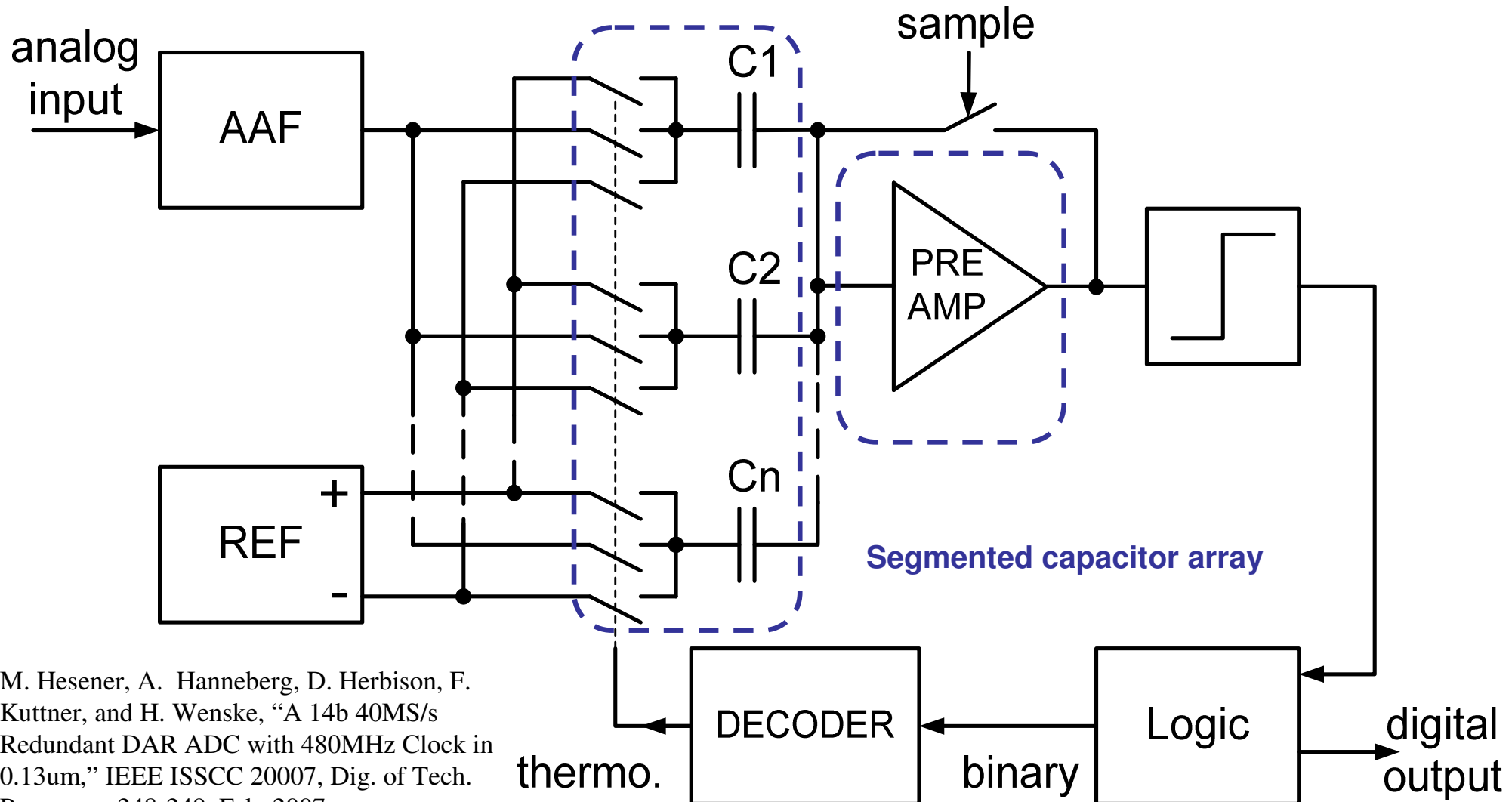
8bit, 0.3mW at 20MHz

J. Craninckx and G. Van der Plas,
“A 65fJ/Conversion-Step 0-to-0.7mW 9b Charge-Sharing SAR ADC in 90nm Digital CMOS,” IEEE ISSCC 2007, Dig. of Tech. Papers, pp.246-247, Feb. 2007.

| ISSCC06 Paper # | Arch. | Fs [MS/s] | ENOB | P [mW] | FoM [fJ] | FoM includes | | |
|------------------|---------------|-----------|------------|-------------|-----------|--------------|------------|------|
| | | | | | | Ref. | Clock | Dec. |
| 3.1 | CTΔΣ | 40 | 12 | 50 | 300 | - | Yes | Yes |
| 3.4 | ΔΣ | 4.4 | 12.6 | 13.8 | 500 | - | No | No |
| 12.1 | PL | 100 | 9.4 | 39 | 570 | - | - | - |
| 12.3 | Subr. | 50 | 10.4 | 30 | 440 | - | - | - |
| 12.4 | PL-CBSC | 7.9 | 8.7 | 2.5 | 760 | - | - | - |
| 12.5 | SAR | 0.1 | 10.5 | 0.025 | 170 | No | No | - |
| 12.7 | PL | 50 | 9.2 | 15 | 510 | - | - | - |
| 31.1 | Flash | 1250 | 3.7 | 2.5 | 160 | - | - | - |
| 31.5 | SAR | 300 | 5.3 | 2.65 | 220 | No | Yes | - |
| This work | CS-SAR | 20 | 7.8 | 0.29 | 65 | Yes | Yes | - |

High resolution and high speed SAR ADC

To increase the resolution, a pre-amplifier is located in front of a comparator



M. Hesener, A. Hanneberg, D. Herbison, F. Kuttner, and H. Wenske, "A 14b 40MS/s Redundant DAR ADC with 480MHz Clock in 0.13um," IEEE ISSCC 2007, Dig. of Tech. Papers, pp.248-249, Feb. 2007.

thermo.

DECODER

binary

Logic

digital output

Results

High conversion rate of 40MS/s and low power of 66mW have been attained

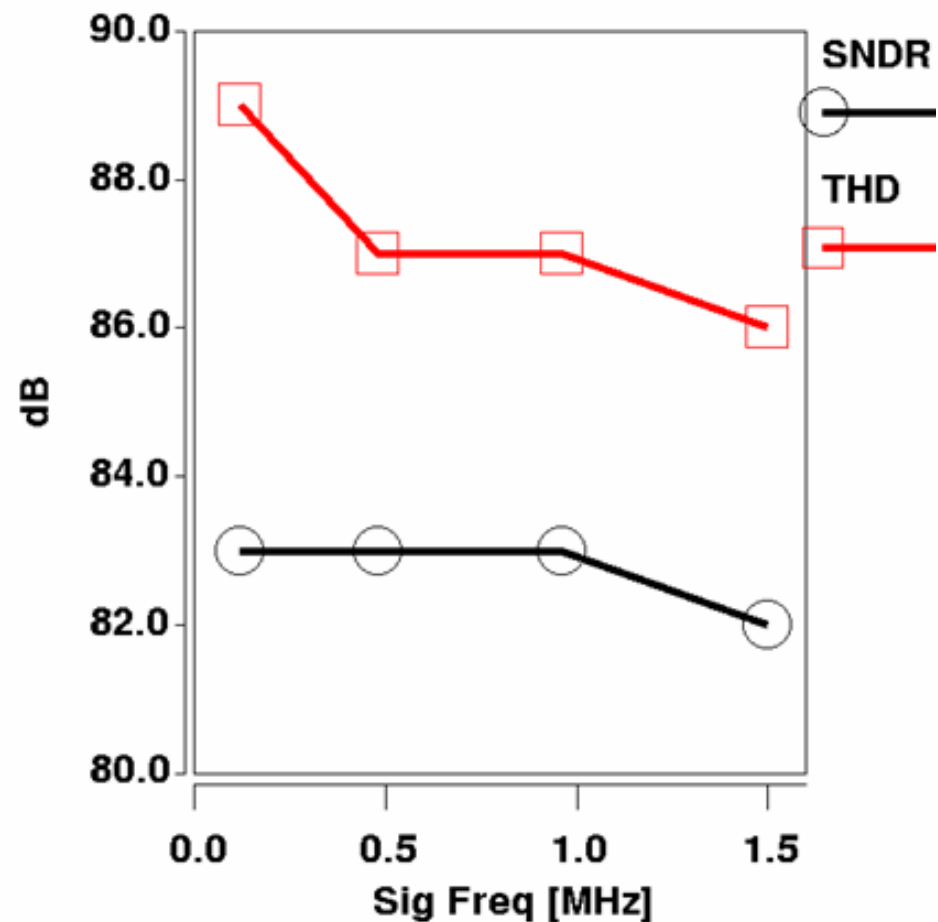
High ENOB of 13.5bit has been attained

FoM=0.14pJ/step

0.13um CMOS

| | |
|--------------------------|-------------|
| Supply voltage | 1.5V |
| Input range | ±0.9V diff. |
| Sample frequency | 40MHz |
| Internal clock frequency | 480MHz |
| Analog power | 49mW |
| Digital power | 17mW |
| Total power | 66mW |

THD & SNDR vs. Signal Frequency



Delta-sigma ADC

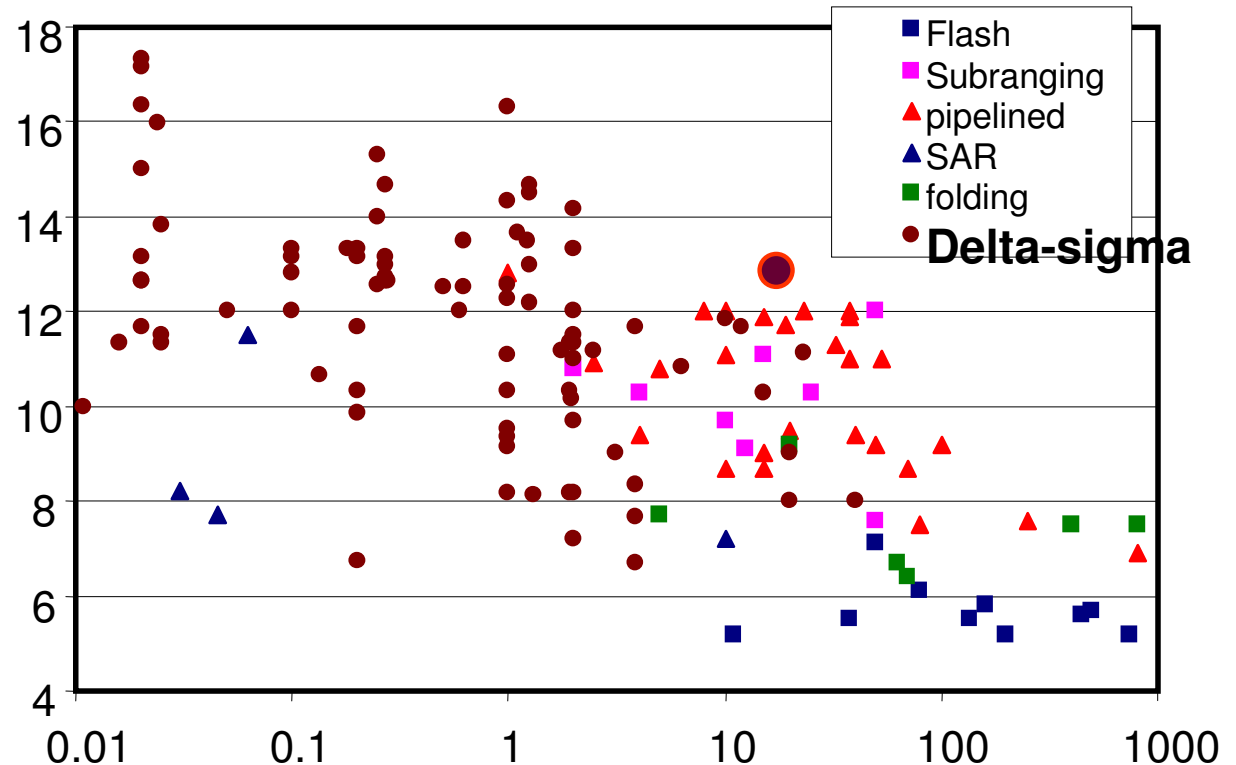
In delta-sigma ADC, higher operating frequency can increase SNR.
For higher resolution ADC, the delta-sigma method must be vital.

Nyquist ADC:

$$SNR \propto CV_{sig}^2$$

Delta-sigma ADC:

$$SNR \propto CV_{sig}^2 \cdot M^\alpha$$



Wide-band delta-sigma ADC

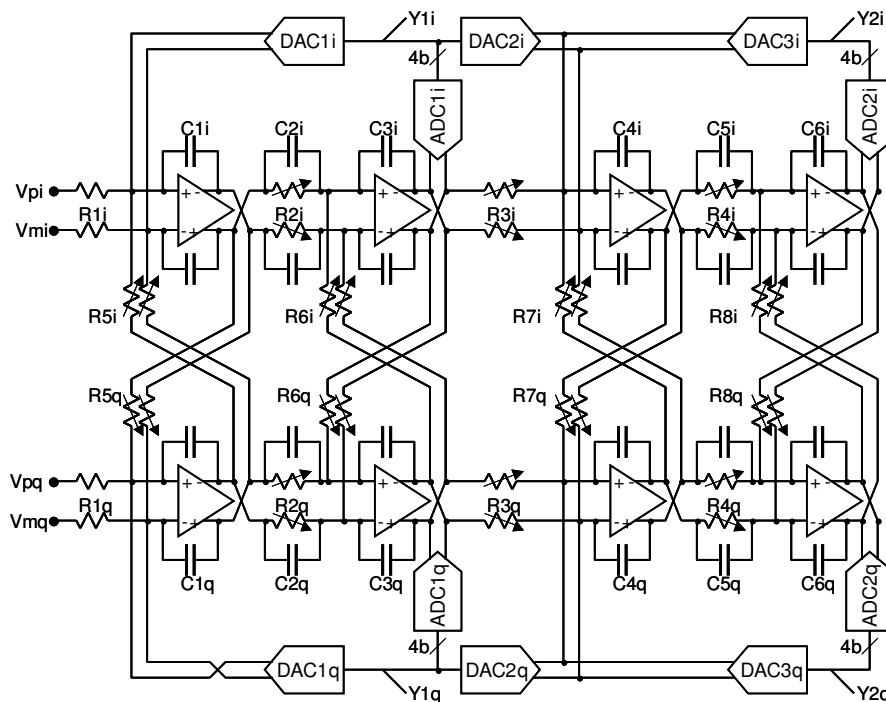
Delta sigma ADCs have emerged as a strong rival to high resolution nyquist ADCs

90nm CMOS, BW=20MHz, DR(=SNR)=77dB, 50mW, FoM=200fJ/conv.

L. J. Breems, et., al.

“A 56mW CT Quadrature Cascaded SD Modulator with 77dB in a Near aero-IF 20MHz Band.

ISSCC 2007, pp. 238-239.



| | |
|-----------------------|---|
| Technology | 90nm CMOS, 1P6M |
| Supply voltage | 1.2V |
| Architecture | CT quadrature cascaded $\Sigma\Delta$ modulator (2-2, 4b) |
| Sampling frequency | 340MHz |
| Bandwidth | 20MHz @ 10.5MHz IF |
| Max. input voltage | 1Vp (differential) |
| Dynamic range* | 77dB (97dB @ 200kHz, 115dB @ 3kHz) |
| Peak SNR / SNDR* | 71dB / 69dB |
| Image rejection | >55dB (for -1MHz input tone) |
| Active chip area | 0.5mm ² |
| Power consumption | 50mW (analog), 6mW (digital) |
| Figure-of-merit (FOM) | 0.2pJ/conv. (FOM=P/(2 ^{enob} *2*BW)) |

(*1MHz input signal, signal bandwidth is 20MHz)

Summary

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- **Technology issues due to technology scaling**
 - Low voltage operation → small headroom
 - Reducing voltage gain
 - Small voltage swing → larger signal capacitance
 - Difficult to realize high resolution ADCs
- **Design challenges of ADCs**
 - **Pipelined ADC**
 - Optimization of OpAmp
 - Comparator controlled current source
 - **Revival of ADC architectures**
 - **No use of OpAmps** ----
 - Sub-ranging ADC
 - SAR ADC
 - **Delta-sigma ADC is increasing signal bandwidth**

FURTHER READING

Click any one of the following links to be taken to a website which contains the following documents.

The following are some recent examples of Asynchronous ADC activity off the web.

[6 bit Asynchronous December 2006](#)
[Asynchronous ADC In CAD Mentor Graphics](#)
[Asynchronous Data Processing System](#)
[ASYNCHRONOUS PARALLEL RESISTORLESS ADC](#)
[Flash Asynchronous Analog-to-Digital Converter](#)
[Novel Asynchronous ADC Architecture](#)
[LEVEL BASED SAMPLING FOR ENERGY CONSERVATION IN LARGE NETWORKS](#)
[A Level-Crossing Flash Asynchronous Analog-to-Digital Converter](#)
[Weight functions for signal reconstruction based on level crossings](#)
[Adaptive Rate Filtering Technique Based on the Level Crossing Sampling](#)
[Adaptive Level-Crossing Sampling Based DSP Systems](#)
[A 0.8 V Asynchronous ADC for Energy Constrained Sensing Applications](#)
[Spline-based signal reconstruction algorithm from multiple level crossing samples](#)
[A New Class of Asynchronous Analog-to-Digital Converters](#)
[Effects of time quantization and noise in level crossing sampling stabilization](#)

Here is some more background information on Analog to Digital converters.

[A 1-GS/s 6-bit 6.7-mW ADC](#)
[A Study of Folding and Interpolating ADC](#)
[Folding ADCs Tutorials](#)
[high speed ADC design](#)
[Investigation of a Parallel Resistorless ADC](#)

Here are some patents on the subject.

[4,291,299 Analog to digital converter using timed](#)
[4,352,999 Zero crossing comparators with threshold](#)
[4,544,914 Asynchronously controllable successive approximation](#)
[4,558,348 Digital video signal processing system using](#)
[5,001,364 Threshold crossing detector](#)
[5,315,284 Asynchronous digital threshold detector](#)
[5,945,934 Tracking analog to digital converter](#)
[6,020,840 Method and apparatus for representing waveform](#)
[6,492,929 Analogue to digital converter and method](#)
[6,501,412 Analog to digital converter including a quantizers](#)
[6,667,707 Analog to digital converter with asynchronous ability](#)
[6,720,901 Interpolation circuit having a conversio2](#)
[6,850,180 SelfTimed ADC](#)
[6,965,338 Cascade A D converter](#)
[7,133,791 Two mean level crossing time interval](#)

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